


<b>Issue Classification</b> 	<b>Application No.</b>	<b>Applicant(s)</b>	
	10/019,390	THOM, FRANK	
	<b>Examiner</b>	<b>Art Unit</b>	
	Dah-Wei D. Yuan	1745	

ISSUE CLASSIFICATION										
ORIGINAL				CROSS REFERENCE(S)						
CLASS		SUBCLASS		CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)					
429		26		429	12	17				
INTERNATIONAL CLASSIFICATION										
H	0	1	M							
				8/12						
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				/						
Dah-Wei Yuan 1/23/04 (Assistant Examiner) (Date)				Patrick Ryan Supervisory Patent Examiner Technology Center 1700 (Primary Examiner) (Date) 12/4/04				Total Claims Allowed: 5		
(Legal Instruments Examiner) (Date)								O.G. Print Claim(s) 1	O.G. Print Fig. 2	

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant				<input type="checkbox"/> CPA				<input type="checkbox"/> T.D.				<input type="checkbox"/> R.1.47			
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